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Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

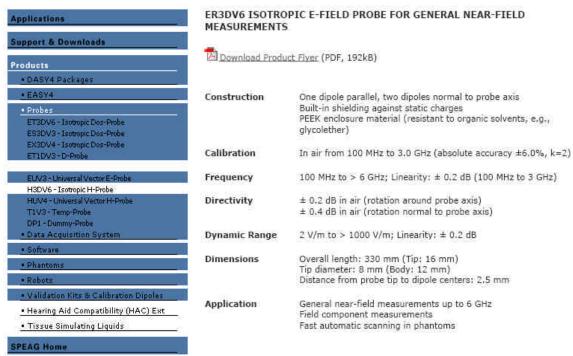
## Annex B: Probe and dipole description and calibration certificates

B.1 Probe, measurement chain description, specification and calibration certificate

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DASY Dosimetric Assessment System by Schmid & Partner Engineering AG



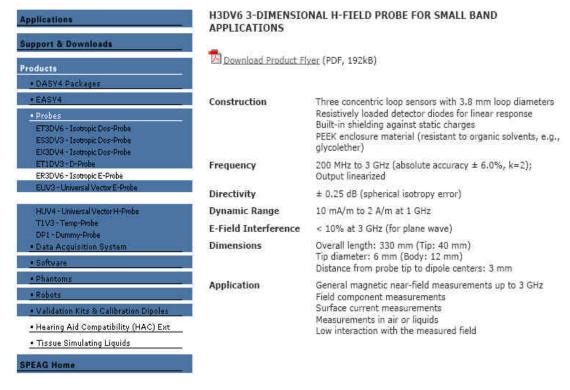


http://www.dasy4.com/er3.htm

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DASY Dosimetric Assessment System by Schmid & Partner Engineering AG





http://www.dasy4.com/h3d.htm

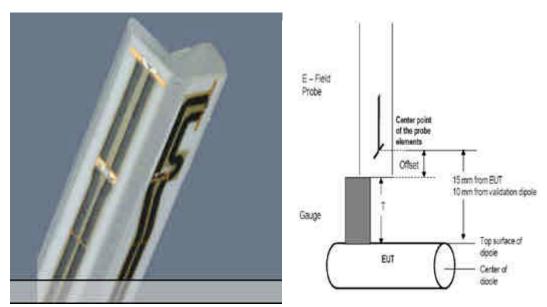
RTS RIM Testing Services		d Compatibility RF Emission rry® Smartphone model RI		Page 4(31)
Author Data	Dates of Test	Report No	FCC ID	
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All measurements were performed to the nearest element point as per the C63.19 standard. Offset distances were entered in the DASY4 software so that the measurement was to the nearest element.

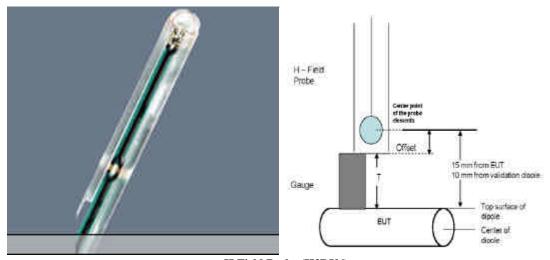
Figures 1 and 2, provided by the manufacturer, illustrate detail of the probe tip and its dimensions.

**ER3DV6** E-Field probe: The distances from the probe tip to the closest points on the dipole sensors are 1.45mm for X and Y and 1.25mm for Z. From the probe tip to the center of the sensors is 2.5mm.

**H3DV6** H-Field probe: The distance from the probe tip to the closest point of the X, Y and Z loop sensors is 1.1mm. From the probe tip to the center of the sensor is 3.00mm.



E-Field Probe (ER3DV6)



H-Field Probe (H3DV6)

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The following information is from the system manufacturer user manual describing the process chain:

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i} \tag{20.1}$$

 $\begin{aligned} &(i=x,\,y,\,z)\\ &(i=x,\,y,\,z)\\ &(DASY\;parameter) \end{aligned}$ with  $V_i$ = compensated signal of channel i  $U_i$ = input signal of channel i cf= crest factor of exciting field = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E – fieldprobes : 
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

$${
m H-field probes}$$
 : 
$$H_i = \sqrt{V_i} \cdot {a_{i0} + a_{i1} f + a_{i2} f^2 \over f}$$

with 
$$V_i$$
 = compensated signal of channel i (i = x, y, z)  
 $Norm_i$  = sensor sensitivity of channel i (i = x, y, z)

 $\mu V/(V/m)^2$  for E-field Probes

= sensitivity enhancement in solution = sensor sensitivity factors for H-field probes

= carrier frequency [GHz]

f  $E_i$ = electric field strength of channel i in V/m = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

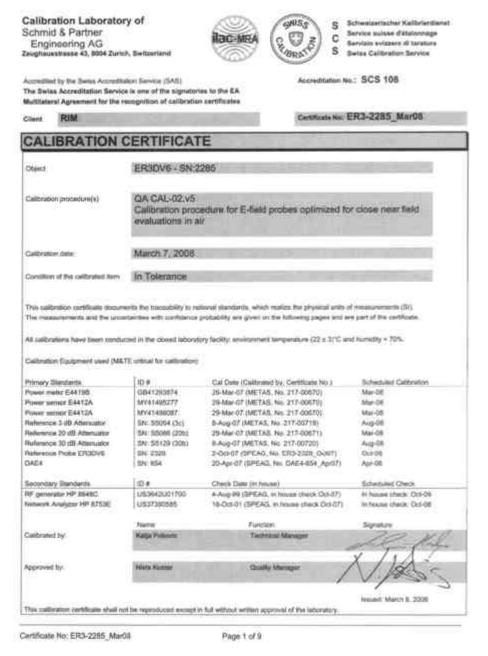
$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$
 (20.2)

The measurement / integration time per point is > 500 ms, as per the system manufacturer:

The time response of the field probes has been assessed by exposing the probe to a well-controlled field producing signals larger than HAC E- and H-fields of class M4. The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500 ms and a probe response time of <5 ms. In the current implementation, DASY4 waits longer than 100 ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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Calibration Laboratory of Schmid & Partner Engineering AG





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Accreditation No.: SCS 108

Accedited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signaturies to the EA Munitateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z DCP

sensitivity in free space diode compression point protation around probe axis

Polarization @ Polarization 8

9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., 5 = 0 is normal to probe axis

Connector Angle

information used in DASY system to asign probe sensor X to the robot

coordinate system

#### Calibration is Performed According to the Following Standards:

 a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

#### Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 8 = 0 for XY sensors and 8 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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March 7, 2008

# Probe ER3DV6

SN:2285

Manufactured: Last calibrated: September 20, 2002

Recalibrated:

March 12, 2007 March 7, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No. ER3-2285, Mar08

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March 7, 2008

Diode Compression<sup>A</sup>

### DASY - Parameters of Probe: ER3DV6 SN:2285

Sensitivity in Free Space [µV/(V/m)<sup>2</sup>]

1.24 ± 10.1 % (k=2) DCP X 93 mV

NormY 1.40 ± 10.1 % (k=2) DCP Y 93 mV NormZ 1.59 ± 10.1 % (k=2) DCP Z 98 mV

Frequency Correction

NormX

X 0.0 Y 0.0 Z 0.0

Sensor Offset (Probe Tip to Sensor Center)

X 2.5 mm Y 2.5 mm Z 2.5 mm

Connector Angle -278 \*

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2265 Mar08

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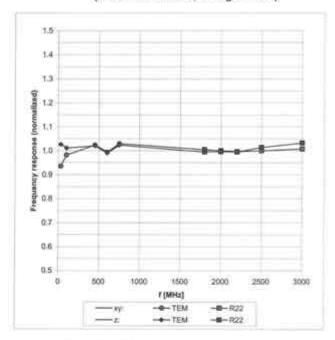
<sup>\*</sup> numerical breambation parameter: incontainty and required

RTS RIM Testing Services		d Compatibility RF Emissio rry® Smartphone model R		Page 10(31)
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March 7, 2008

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

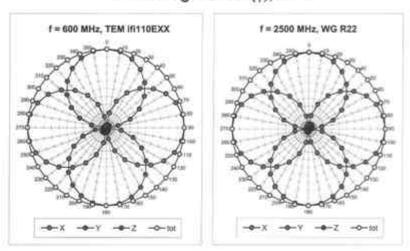
Certificate No: ER3-2285\_Mar08

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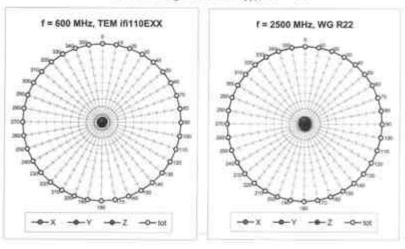
RTS RIM Testing Services		d Compatibility RF Emission rry® Smartphone model R		Page 11(31)
Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

ER3DV6 SN:2285 March 7, 2008

### Receiving Pattern ( $\phi$ ), $\theta$ = 0°



## Receiving Pattern (φ), θ = 90°



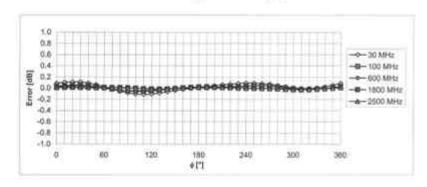
Certificate No: ER3-2285\_Mar08

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RTS RIM Testing Services	•	d Compatibility RF Emission rry® Smartphone model F		Page 12(31)
Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

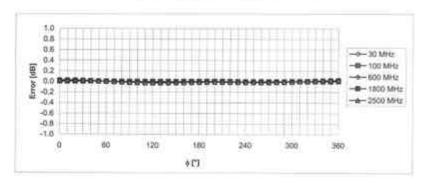
March 7, 2008

### Receiving Pattern (6), 9 = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

### Receiving Pattern (4), 9 = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ER3-2265\_Mar06

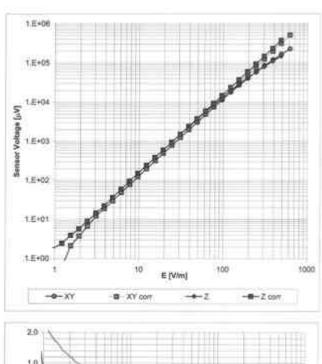
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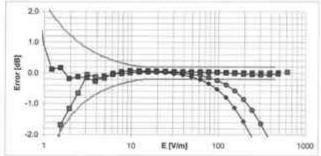
RTS RIM Testing Services		d Compatibility RF Emissio rry® Smartphone model R		Page 13(31)
Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40GV	W

March 7, 2008

### Dynamic Range f(E-field)

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k×2)

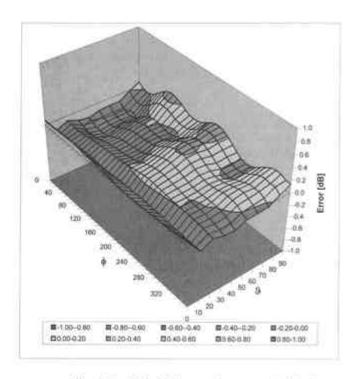
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March 7, 2008

# Deviation from Isotropy in Air Error ( $\phi$ , $\vartheta$ ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2265\_Mar08

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

RIM Certificate No: ER3-2286\_Jan08 CALIBRATION CERTIFICATE ER3DV6 - SN:2286 Object QA CAL-02.v5 Calibration procedure for E-field probes optimized for close near field evaluations in air January 21, 2008 Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70% Calibration Equipment used (M&TE critical for calibration) Cel Date (Calibrated by, Certificate No.) 29-Mar-07 (METAS, No. 217-00670) Scheduled Calibration GB41293874 Mar-08 Power meter E4419B 29-Mar-07 (METAS, No. 217-00670) 29-Mar-07 (METAS, No. 217-00670) Power sensor E4412A MY41495277 Mar-08 MY41498087 Power sensor E4412A 8-Aug-07 (METAS, No. 217-00719) 29-Mar-07 (METAS, No. 217-00671) Aug-08 Mar-08 Reference 3 dB Attenuator SN: \$5054 (3c) Reference 20 dB Attenuator SN: S5086 (20b) Reference 30 dB Attenuator SN: 85129 (30b) 8-Aug-07 (METAS, No. 217-00720) Aug-08 Reference Probe ER3DV6 2-Oct-07 (SPEAG, No. ER3-2328\_Oct07) DAE4 SN: 654 20-Apr-07 (SPEAG, No. DAE4-654, Apr07) Apr-08 Secondary Standards Check Date (in house) Schoduled Check RF generator HP 8648C Network Analyzer HP 8753E 4-Aug-99 (SPEAG, in house check Oct-07) 18-Oct-01 (SPEAG, in house check Oct-07) In house check: Oct-09 In house check: Oct-08 US3642U01700 US37390585 Function Katja Pokovic Approved by: Quality Manage This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2286\_Jan08

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Calibration Laboratory of Schmid & Partner

Engineering AG aughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Corrice (CAS).

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point Polarization φ o rotation around probe axis

3 rotation arounc an axis that is in the plane normal to probe axis (at Polarization 8

measurement center), i.e., 9 = 0 is normal to probe axis

information used in DASY system to align probe sensor X to the robot Connector Angle

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, \* IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz', December 2005.

#### Methods Applied and Interpretation of Parameters:

- NORMx,y.z: Assessed for E-field polarization 8 = 0 for XY sensors and 8 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z \* irequency\_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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January 21, 2008

## Probe ER3DV6

SN:2286

Manufactured: September 19, 2002 Last calibrated: January 10, 2007 Recalibrated: January 21, 2008

Calibrated for DASY Systems
(Note: non-compatible with DASY2 system!)

Certificate No: ER3-2286\_Jan08

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January 21, 2008

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### DASY - Parameters of Probe: ER3DV6 SN:2286

Diode Compression<sup>A</sup> Sensitivity in Free Space [µV/(V/m)<sup>2</sup>] 2.20 ± 10.1 % (k=2) DCP X 94 mV NormX 1.44 ± 10.1 % (k=2) DCP Y 94 mV NormY 1.54 ± 10.1 % (k=2) DCP Z 95 mV NormZ Frequency Correction 0.0 X Y 0.0 Z 0.0 Sensor Offset (Probe Tip to Sensor Center) X 2.5 mm Y 2.5 mm 2.5 mm Z Connector Angle -187 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2286\_Jan08

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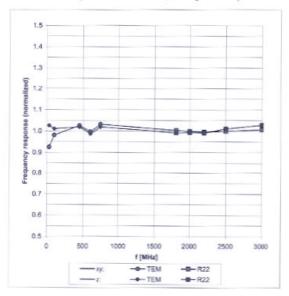
<sup>\*</sup> numerical linearization parameter, uncertainty not required

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January 21, 2008

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

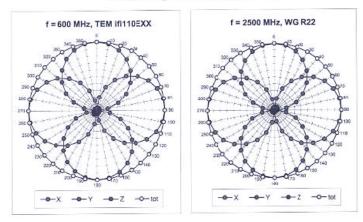
Certificate No: ER3-2286\_Jan08

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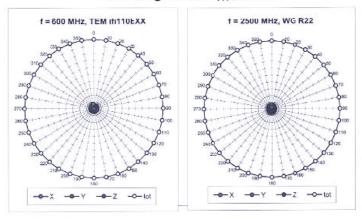
RTS RIM Testing Services		l Compatibility RF Emissio rry® Smartphone model R		Page 20(31)
Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

January 21, 2008

### Receiving Pattern (6), 9 = 0°



### Receiving Pattern (φ), $\vartheta$ = 90°



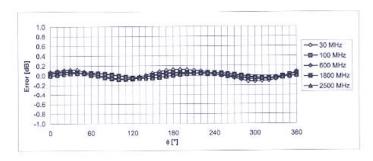
Certificate No: ER3-2286\_Jan08

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RTS RIM Testing Services		l Compatibility RF Emissio rry® Smartphone model R		Page 21(31)
Author Data	Dates of Test	Report No	FCC ID	
Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

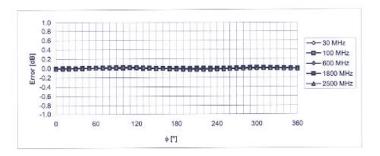
January 21, 2008

#### Receiving Pattern (φ), 9 = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

#### Receiving Pattern (\$\phi\$), \$\theta = 90°



Uncertainty of Axial Isotropy Assessment; ± 0.5% (k=2)

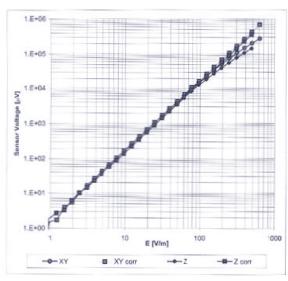
Certificate No: ER3-2286\_Jan08

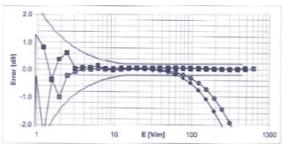
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Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

January 21, 2008

## Dynamic Range f(E-field) (Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

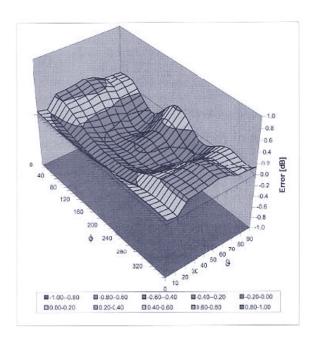
Certificate No: ER3-2286\_Jan08

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Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40GW	

January 21, 2008

# Deviation from Isotropy in Air Error $(\phi, \vartheta)$ , f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2286\_Jan08

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Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40G	W

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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RIM

Certificate No. H3-6105 Nov07

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE H3DV6 - SN:6105 Object Calibration procedure(s) QA CAL-03.V5 Calibration procedure for H-field probes optimized for close near field evaluations in air Calibration date: November 9, 2007 Condition of the calcusted Item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (51). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility, environment temperature (22  $\pm$  3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Cat Date (Calibrated by, Certificate No.) Scheduled Calibration Primary Standards GB41293E74 29-Mar-07 (METAS, No. 217-00670) Mar-Off Power meter E44199 Power sensor E4412A MY41495277 29-Mar-07 (METAS, No. 217-00670) Mar-Off MY41498087 29-Mar-07 (METAS, No. 217-00670) May-DE Power sensor E4412A 5-Aug-07 (METAS, No. 217-00719) Aug-08 SN: \$5054 (3c) Reference 3 dB Attenuator 29-Mar-07 (METAS, No. 217-00671) SN: 85086 (20b) Mar-08 Reference 20 dB Attenuator SN: \$5129 (30b) 8-Aug-07 (METAS, No. 217-00720) Aug-06 Reference 30 dB Attenuator 2-Oct-07 (SPEAG, No. H3-6182 Oct07) Oct-08 Reference Probe HIIDWI SN: 6182 20-Apr 07 (SPEAG, No. DAE4-654\_Apr 07) DAE4 SN: 654 Apri-08 Secondary Standards Check Date (in house) Scheduled Check RF generator HP 8648C US3642UD1700 4-Aug-89 (SPEAG, in house check Oct-07) in house check: Oct-09 Network Analyzer HP 8753E US37390585 18-Oct-01 (SPEAG, in house check Oct-07) In house check: Oct-08 **Function Technical Manager** Calibrated by: Кици Рокочю Quality Morroger Aggroved by: Ninits Youtter Issued: November 12, 2007 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Daoud Attayi	July 29, Sep 26-27, 2008	RTS-1115-0809-31 Rev1	L6ARBZ40GV	W

#### Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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C Service suisse d'étalonnage
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S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary:

NORMx,y,z sensitivity in free space
DCP diode compression point
Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., 9 = 0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot

coordinate system

### Calibration is Performed According to the Following Standards:

 a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

#### Methods Applied and Interpretation of Parameters:

- X,Y,Z\_a0a1a2: Assessed for E-field polarization 9 = 90 for XY sensors and 8 = 0 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)\_a0a1a2= X,Y,Z\_a0a1a2\* frequency\_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset. The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X a0a1a2 (no uncertainty required).

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# Probe H3DV6

SN:6105

Manufactured: January 4, 2002
Last calibrated: November 15, 2006
Recalibrated: November 9, 2007

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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### DASY - Parameters of Probe: H3DV6 SN:6105

Sensitivity in Free Space [A/m / √(µV)]

a0 a1 a2 X 2.879E-03 7.363E-5 -1.925E-5 ± 5.1 % (k=2) Y 2.588E-03 1.222E-4 -1.861E-5 ± 5.1 % (k=2) Z 2.929E-03 -6.729E-6 -1.558E-5 ± 5.1 % (k=2)

Diode Compression<sup>1</sup>

DCP X 87 mV DCP Y 87 mV DCP Z 87 mV

Sensor Offset (Probe Tip to Sensor Center)

X 3.0 mm Y 3.0 mm Z 3.0 mm

Connector Angle -234 \*

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

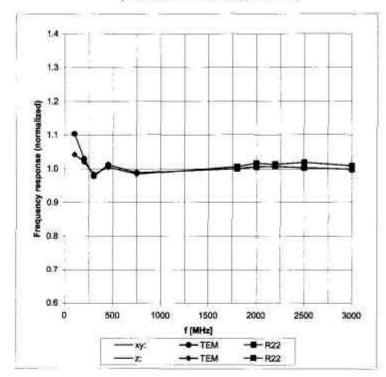
<sup>&</sup>lt;sup>3</sup> numerical linearization parameter: uncertainty not required

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## Frequency Response of H-Field

(TEM-Cell:ifi110, Wavegulde R22)

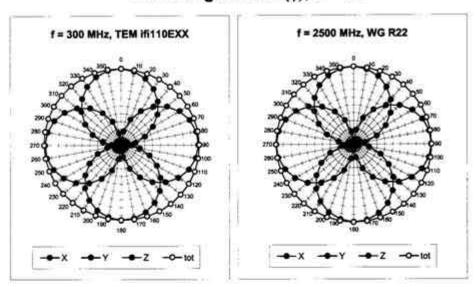


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

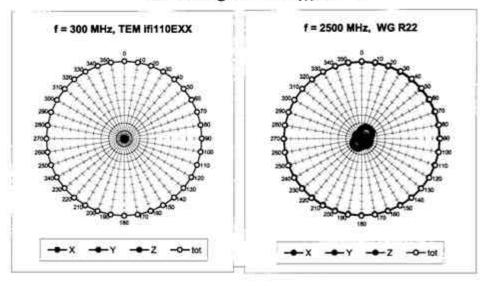
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## Receiving Pattern ( $\phi$ ), $\vartheta$ = 90°



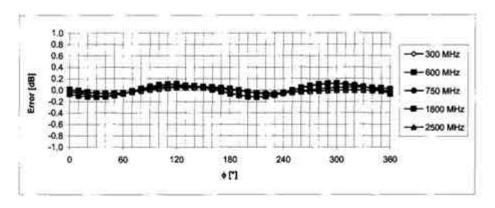
## Receiving Pattern ( $\phi$ ), $\vartheta$ = 0°



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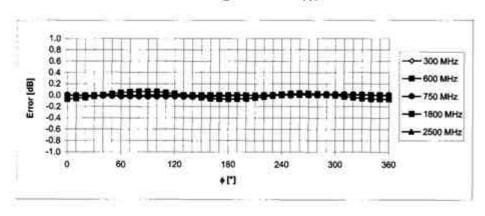
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## Receiving Pattern (φ), 9 = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern ( $\phi$ ),  $\vartheta = 0^{\circ}$ 



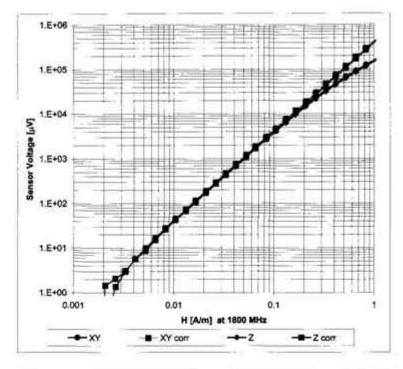
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

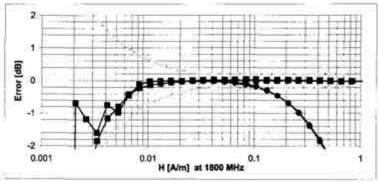
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## Dynamic Range f(H-field)

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)